TSG-RAN meeting #18   **RP-020777**
New Orleans, US 3-6 December 2002

Source: TSG RAN WG4

Title: List of agreed CRs from RAN WG4

Agenda item: 7.4.1

TSG Tdoc	Spec	CR	R	Cat	Rel	Title	Work Item
RP-020778	25.101	194		F	R99	Correction for TPC combining test case 1	TEI
RP-020778	25.101	196		A	Rel-4	Correction for TPC combining test case 1	TEI
RP-020778	25.101	195		A	Rel-5	Correction for TPC combining test case 1	TEI
RP-020779	25.105	131		F	R99	Spurious emission requirements for unsynchronized TDD operation	TEI
RP-020779	25.105	132		F	Rel-4	Spurious emission requirements for unsynchronized TDD operation	TEI4
RP-020779	25.105	133		F	Rel-5	Spurious emission requirements for unsynchronized TDD operation	TEI5
RP-020780	25.133	437	1	F	R99	Correction of interruption time in FDD/FDD Hard Handover	TEI
RP-020780	25.133	438	1	A	Rel-4	Correction of interruption time in FDD/FDD Hard Handover	TEI
RP-020780	25.133	439	1	A	Rel-5	Correction of interruption time in FDD/FDD Hard Handover	TEI
RP-020780	25.133	476		F	R99	Correction of UE Transmitted Power requirements in case of Compressed Mode gaps	TEI
RP-020780	25.133	488		A	Rel-4	Correction of UE Transmitted Power requirements in case of Compressed Mode gaps	TEI
RP-020780	25.133	477		A	Rel-5	Correction of UE Transmitted Power requirements in case of Compressed Mode gaps	TEI
RP-020780	25.133	478	1	F	R99	Correction of Measurement Occasion Patterns for BSIC Reconfirmation	TEI
RP-020780	25.133	489	1	A	Rel-4	Correction of Measurement Occasion Patterns for BSIC Reconfirmation	TEI
RP-020780	25.133	479	1	A	Rel-5	Correcction of Measurement Occasion Patterns for BSIC Reconfirmation	TEI
RP-020780	25.133	480	2	F	R99	Required Window size for measurements using IPDL	TEI
RP-020780	25.133	490	2	A	Rel-4	Required Window size for measurements using IPDL	TEI
RP-020780	25.133	481	2	A	Rel-5	Required Window size for measurements using IPDL	TEI
RP-020780	25.133	482	1	F	R99	UE Timer accuracy	TEI
RP-020780	25.133	491	1	A	Rel-4	UE Timer accuracy	TEI
RP-020780	25.133	483	1	A	Rel-5	UE Timer accuracy	TEI
RP-020780	25.133	504		F	R99	Correction of UE parameters for Random Access Test	TEI

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RP-020780	25.133	505		A	Rel-4	Correction of UE parameters for Random Access Test	TEI
RP-020780	25.133	506		A	Rel-5	Correction of UE parameters for Random Access Test	TEI
RP-020781	25.104	167		F	R99	FDD GSM co-existence in the Same Geographic Area	TEI
RP-020781	25.104	149	1	A	Rel-4	FDD GSM co-existence in the Same Geographic Area	TEI
RP-020781	25.104	153		A	Rel-5	FDD GSM co-existence in the Same Geographic Area	TEI
RP-020781	25.104	150		F	Rel-5	FDD GSM 850 / PCS 1900 co-existence in the Same Geographic Area	TEI5
RP-020781	25.141	264		F	R99	FDD GSM co-existence in the Same Geographic Area	TEI
RP-020781	25.141	250	1	A	Rel-4	FDD GSM co-existence in the Same Geographic Area	TEI
RP-020781	25.141	252		A	Rel-5	FDD GSM co-existence in the Same Geographic Area	TEI
RP-020781	25.141	251		F	Rel-5	FDD GSM 850 / PCS 1900 co-existence in the Same Geographic Area	TEI5
RP-020782	25.102	129		F	Rel-4	Introduction of Rel-5 clarifications and small corrections in Rel-4	TEI4
RP-020782	25.102	130		F	Rel-4	Name correction of logical and transport channels	TEI4
RP-020782	25.102	131		A	Rel-5	Name correction of logical and transport channels	TEI4
RP-020783	25.104	161		F	Rel-4	Correction to table of regional requirements	TEI4
RP-020783	25.104	162		A	Rel-5	Correction to table of regional requirements	TEI4
RP-020784	25.105	128	1	F	Rel-4	Introduction of Rel-5 clarifications and small corrections in Rel-4	TEI4
RP-020784	25.105	129		F	Rel-4	Name correction of logical and transport channels	TEI4
RP-020784	25.105	130		A	Rel-5	Name correction of logical and transport channels	TEI4
RP-020785	25.106	015		F	Rel-4	Aligning of the requirement for "Output power" in extreme conditions with TS25.143	RlnImp-REP
RP-020785	25.106	016		A	Rel-5	Aligning of the requirement for "Output power" in extreme conditions with TS25.143	RlnImp-REP
RP-020786	25.123	279		F	Rel-4	Handover Test Case Correction for 1.28Mcps TDD	LCRTDD-RF
RP-020786	25.123	280		A	Rel-5	Handover Test Case Correction for 1.28Mcps TDD	LCRTDD-RF
RP-020786	25.123	281		F	Rel-4	Maximum allowed UL TX Power Correction for 1.28Mcps TDD	LCRTDD-RF
RP-020786	25.123	282		A	Rel-5	Maximum allowed UL TX Power Correction for 1.28Mcps TDD	LCRTDD-RF
RP-020786	25.123	283		F	Rel-4	Corrections to Idle Mode Requirements and Test Cases for 1.28Mcps TDD	LCRTDD-RF
RP-020786	25.123	284		A	Rel-5	Corrections to Idle Mode Requirements and Test Cases for 1.28Mcps TDD	LCRTDD-RF
RP-020787	25.133	503		F	Rel-4	Total received power density definition for the BS	TEI4
RP-020787	25.133	498	1	A	Rel-5	Total received power density definition for the BS	TEI4
RP-020788	25.141	257	1	F	Rel-4	General corrections to TS 25.141	TEI4
RP-020788	25.141	258	1	A	Rel-5	General corrections to TS 25.141	TEI4
RP-020788	25.141	260		F	Rel-4	Transmit intermodulation test correction	TEI4
RP-020788	25.141	261		A	Rel-5	Transmit intermodulation test correction	TEI4
RP-020789	25.142	147	1	F	Rel-4	Introduction of Rel-5 clarifications and small corrections in Rel-4	TEI4

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RP-020789	25.142	148		F	Rel-4	Averaging period in ACLR test for 1.28 Mcps TDD option	LCRTDD-RF
RP-020789	25.142	149		A	Rel-5	Averaging period in ACLR test for 1.28 Mcps TDD option	LCRTDD-RF
RP-020790	25.143	013	1	F	Rel-4	New test environment: Extreme power supply for output power test	RInImp-REP
RP-020790	25.143	014	1	A	Rel-5	New test environment: Extreme power supply for output power test	RInImp-REP
RP-020790	25.143	015	1	F	Rel-4	Addition of Repeater configuration	RInImp-REP
RP-020790	25.143	016	1	A	Rel-5	Addition of Repeater configuration	RInImp-REP
RP-020790	25.143	017		F	Rel-4	Definition of the power to select the right table for the spectrum emission mask requirement.	RInImp-REP
RP-020790	25.143	018		A	Rel-5	Definition of the power to select the right table for the spectrum emission mask requirement.	RInImp-REP
RP-020790	25.143	023		F	Rel-4	Spurious emission: correction of the procedure	RInImp-REP
RP-020790	25.143	024		A	Rel-5	Spurious emission: correction of the procedure	RInImp-REP
RP-020790	25.143	028		F	Rel-4	EVM Test: Change from Test Model 4 to Test Model 1	RInImp-REP
RP-020790	25.143	020		A	Rel-5	EVM Test: Change from Test Model 4 to Test Model 1	RInImp-REP
RP-020791	25.104	159	1	F	Rel-4	BS IPDL requirement	TEI4
RP-020791	25.104	160	1	A	Rel-5	BS IPDL requirement	TEI4
RP-020791	25.141	255	1	F	Rel-4	BS IPDL test	TEI4
RP-020791	25.141	256	1	A	Rel-5	BS IPDL test	TEI4
RP-020792	25.113	018	1	F	Rel-4	New exclusion bands, requirements for telecommunication port and interpretation of measurement results	TEI4
RP-020792	25.113	019	1	A	Rel-5	New exclusion bands, requirements for telecommunication port and interpretation of measurement results	TEI4
RP-020792	34.124	009		F	Rel-4	New exclusion bands and interpretation of measurement results	TEI4
RP-020792	34.124	010		A	Rel-5	New exclusion bands and interpretation of measurement results	TEI4
RP-020793	25.106	019		F	Rel-4	EVM Test: Change requirement for the use of HSDPA.	RInImp-REP, HSDPA-RF
RP-020793	25.106	010		A	Rel-5	EVM Test: Change requirement for the use of HSDPA.	RInImp-REP, HSDPA-RF
RP-020793	25.143	027		F	Rel-4	EVM Test: Change requirement for the use of HSDPA.	RInImp-REP, HSDPA-RF
RP-020794	25.106	017		F	Rel-4	Out of band gain	RInImp-REP
RP-020794	25.106	018		A	Rel-5	Out of band gain	RInImp-REP
RP-020794	25.143	025		F	Rel-4	Out of band gain	RInImp-REP
RP-020794	25.143	026		A	Rel-5	Out of band gain	RInImp-REP
RP-020795	25.106	011	1	F	Rel-4	Input intermodulation: Correction of co-location and addition of co-existence	RInImp-REP
RP-020795	25.106	012	1	A	Rel-5	Input intermodulation: Correction of co-location and addition of co-existence	RInImp-REP

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RP-020795	25.143	021	1	F	Rel-4	Input intermodulation: Correction of co-location and addition of co-existence	RInImp-REP
RP-020795	25.143	022	1	A	Rel-5	Input intermodulation: Correction of co-location and addition of co-existence	RInImp-REP
RP-020796	25.104	163		F	Rel-5	General Release 5 corrections	TEI5
RP-020796	25.104	166		F	Rel-5	Clarification of TX diversity requirements	TEI5
RP-020797	25.123	285		F	Rel-5	P-CCPCH RSCP and CPICH RSCP signalling range extension	LCRTDD-RF
RP-020798	25.133	502	1	F	Rel-5	CPICH RSCP report mapping	TEI5
RP-020799	25.141	259		F	Rel-5	General Release 5 corrections	TEI5
RP-020799	25.141	263	1	F	Rel-5	Addition of TX Diversity timing accuracy test	TEI5
RP-020800	25.991	001		F	Rel-5	Correction to Pilot Interference Mitigation Technical Report	RInImp-UERecPerf
RP-020801	25.105	134		F	Rel-5	Correction of adjacent channel leakage power definition	TEI5
RP-020801	25.142	150		F	Rel-5	Correction of adjacent channel leakage power definition	TEI5
RP-020802	25.104	148	1	B	Rel-6	Introduction of Base Station Classes	RInImp-BSClass-FDD
RP-020802	25.133	474		B	Rel-6	RRM requirement changes for FDD Base Station Classification	RInImp-BSClass-FDD
RP-020802	25.133	497		B	Rel-6	Changes in TS25.133 according to FDD Local area BS	RInImp-BSClass-FDD
RP-020802	25.141	249	1	B	Rel-6	Introduction of Base Station Classes	RInImp-BSClass-FDD
RP-020802	25.942	010		B	Rel-6	Blocking scenarios for Medium Range BS in FDD mode	RInImp-BSClass-FDD
RP-020803	25.101	198		F	Rel-5	Correction to Specified TBS for HSDPA Reference Channels	HSDPA-RF
RP-020803	25.101	200	1	B	Rel-5	Introduction of requirements for HSDPA UE categories 11 and 12	HSDPA-RF
RP-020803	25.102	127	1	B	Rel-5	Addition of HSDPA UE requirements for 3,84 Mcps TDD option for 16QAM and QPSK for fixed reference channels	HSDPA-RF
RP-020803	25.102	128	1	B	Rel-5	Addition of HSDPA UE requirements for 3,84 Mcps TDD option for 16QAM and QPSK for variable reference channels	HSDPA-RF
RP-020803	25.102	132	1	F	Rel-5	HSDPA UE requirements for 1.28 Mcps TDD option for 16QAM and QPSK for fixed reference channels	HSDPA-RF
RP-020803	25.141	247		F	Rel-5	Correction on PN9 seed setting in Test Model 5	HSDPA-RF
RP-020803	25.142	146	1	F	Rel-5	Correction of 16QAM EVM/PCDE testing for HSDPA for 3,84 Mcps TDD option	HSDPA-RF
RP-020804	25.105	135	1	F	R99	Corrections to 3.84 Mcps TDD reference measurement channels	TEI
RP-020804	25.105	136		A	Rel-4	Corrections to 3.84 Mcps TDD reference measurement channels	TEI
RP-020804	25.105	137		A	Rel-5	Corrections to 3.84 Mcps TDD reference measurement channels	TEI

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RP-020804	25.105	138	1	F	Rel-4	Corrections to 1.28 Mcps TDD reference measurement channels	LCRTDD-RF
RP-020804	25.105	139		A	Rel-5	Corrections to 1.28 Mcps TDD reference measurement channels	LCRTDD-RF
RP-020804	25.142	151		F	R99	Corrections to TDD 3.84Mcps Reference Measurement Channels	TEI
RP-020804	25.142	152		A	Rel-4	Corrections to TDD 3.84Mcps Reference Measurement Channels	TEI
RP-020804	25.142	153		A	Rel-5	Corrections to TDD 3.84Mcps Reference Measurement Channels	TEI4
RP-020804	25.142	154		F	Rel-4	Corrections to TDD 1.28Mcps Reference Measurement Channels	LCRTDD-RF
RP-020804	25.142	155		A	Rel-5	Corrections to TDD 1.28Mcps Reference Measurement Channels	LCRTDD-RF